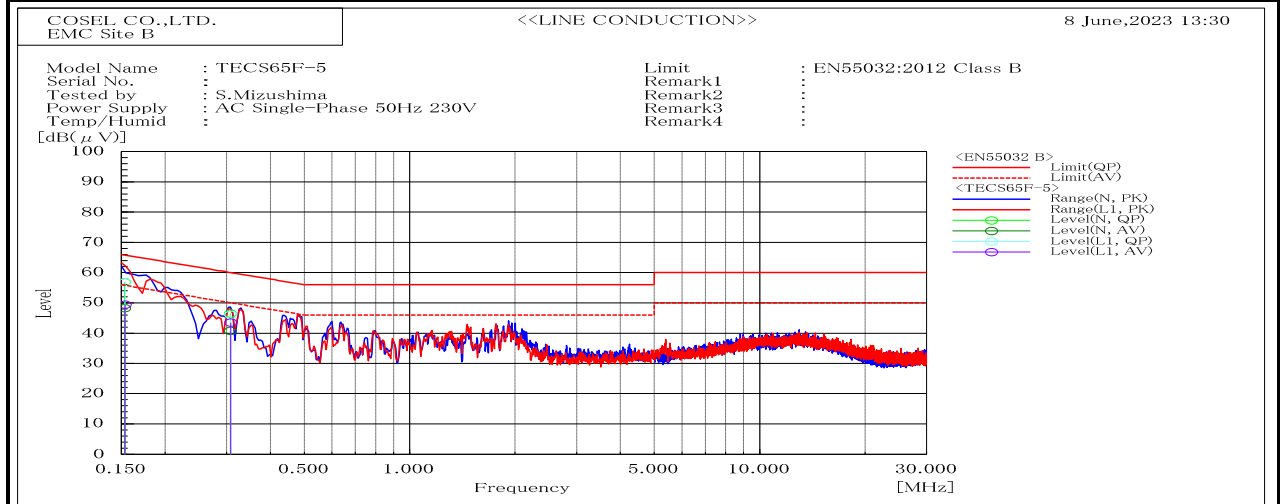
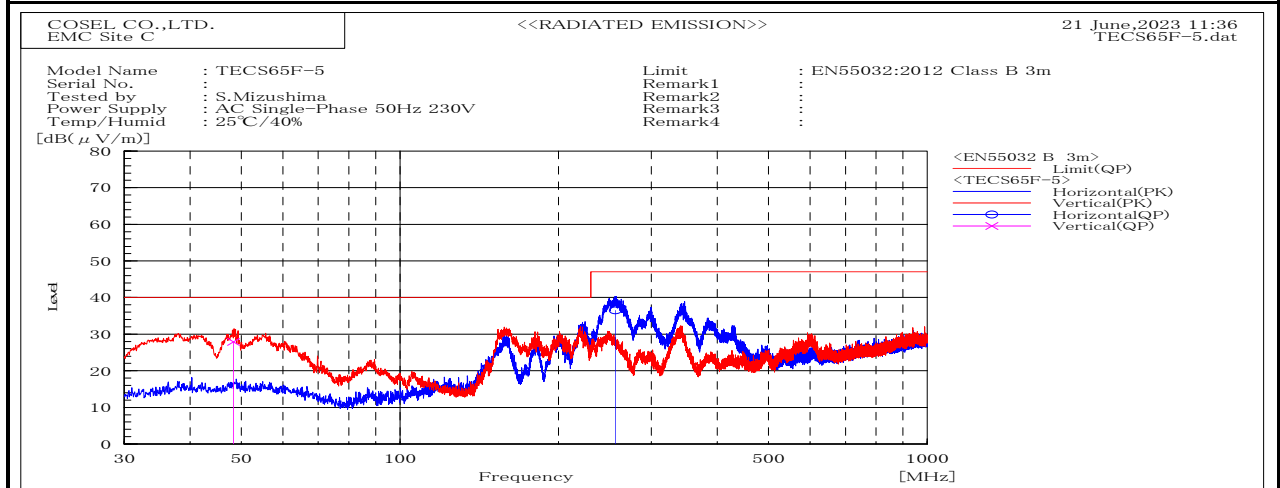


DATA SHEET		Date	12-Oct-23
Model	TECS65F-5	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	S.Mizushima



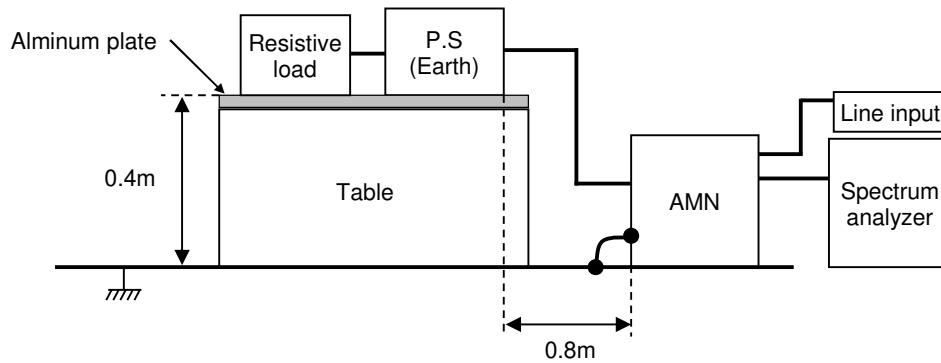
Frequency	Line	Level		Limit		Margin		Pass/Fail	Remark
MHz		dB(μV)		dB(μV)		dB			
		QP	AV	QP	AV	QP	AV		
0.154	L1	56.9	49.4	65.8	55.8	8.9	6.4	Pass	
0.308	L1	46.1	43.5	60	50	13.9	6.5	Pass	
0.153	N	56.9	48.2	65.8	55.8	8.9	7.6	Pass	
0.308	N	46.5	40.7	60	50	13.5	9.3	Pass	



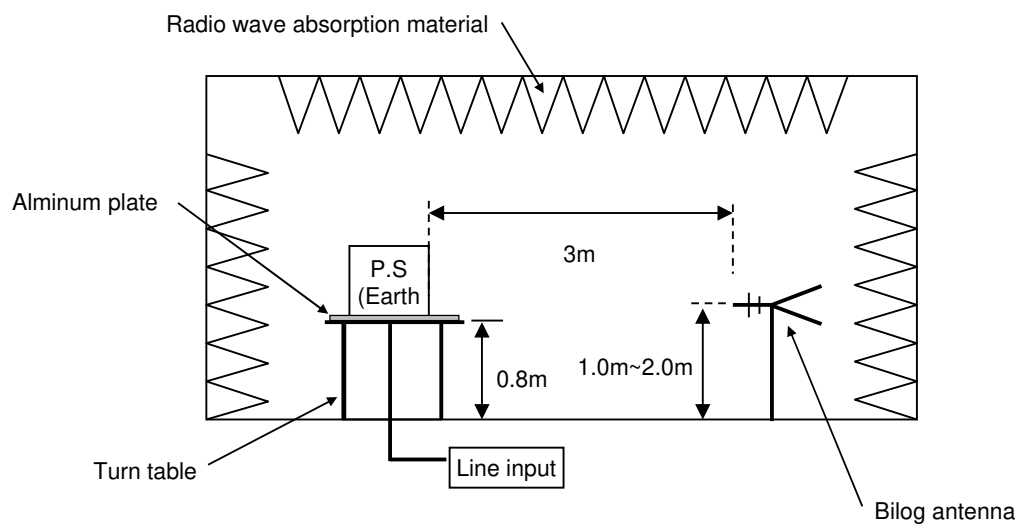
Frequency	Polarization	Stability	Level	Limit	Margin	Pass/Fail	Height	Angle	Remark
MHz			dB(μV/m)	dB(μV/m)	dB				
			QP	QP	QP				
255.988	H	Stable	36.5	47	10.5	Pass	112.4	43.1	
48.313	V	Stable	27.9	40	12.1	Pass	100.2	227.7	

DATA SHEET		Date	12-Oct-23
Model	Circuit used for measurement	Temp.	25 degreeC
Test	EMI Line conduction & Radiated emission	Humid.	40 %RH
		Tested by	S.Mizushima

### 1. Line conduction



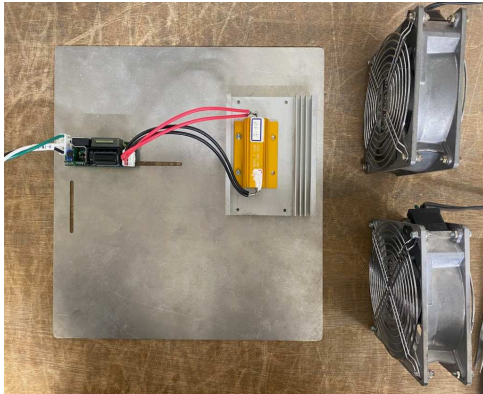
### 2. Radiated emission



## Conditions

Test : EMI  
Model Nam: TECS65F-5

### 1.LINE CONDUCTION



### 2.RADIATED EMISSION

